## Applicant(s)/Patent Under Application/Control No. Reexamination 09/755,627 GEIER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Vincent F. Boccio 2616 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-6,580,870 B1 06-2003 Kanazawa et al. 386/125 US-2002/0007493 01-2002 В BUTLER et al. 725/110 С US-D US-US-Ε F US-US-G US-Н US-J US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS**

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